Notice of References Cited Application/Control No. 10/621,958 Examiner David J Venci David J Venci Applicant(s)/Patent Under Reexamination LOCKE ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0106150	06-2004	Wang, Yingqi Karen	435/007.1
	В	US-2004/0005633	01-2004	Vandekerckhove et al.	435/7.1
	С	US-2003/0068825	04-2003	Washburn et al.	436/86
	D	US-2002/0076817	06-2002	Figeys et al.	436/6
	Е	US-6,670,194	12-2003	Aebersold et al.	436/173
	F	US-6,475,807	11-2002	Geysen et al.	436/518
	G	US-6,391,649	05-2002	Chait et al.	436/173
	Н	US-			
	ı	US-			
	J	US-	:		
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	,N				* *	
	0				·	
	Р				,	
	Q					
	R					
30	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	ט	
	>	
	W	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.